Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/563,381	BRANCHESI ET AL.
Examiner	Art Unit
Dimple N. Bodawala	1722

SEARCHED				
Class	Subclass	Date	Examiner	
249	160,163, 168,117	4/20/2007	DB	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor's ma,e search on eDAN	4/20/2007	DB	